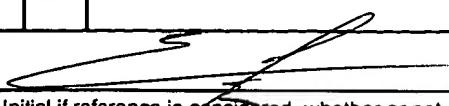
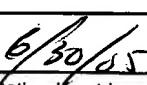


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 215231US2S	SERIAL NO. 09/987,881	
<p style="text-align: center;"><b>O I P E</b></p> <p>LIST OF REFERENCES CITED BY APPLICANT</p> <p>FEB 13 2002</p> <p>PATENT &amp; TRADEMARK OFFICE</p>		APPLICANT		Takashi SEKI, et al.		
		FILING DATE		November 16, 2001		
				GROUP		
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
AA						
AB						
AC						
AD						
AE						
AF						
AG						
AH						
AI						
AJ						
AK						
AL						
AM						
AN						
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO 2954570	09/27/99	JAPAN	<input type="checkbox"/> YES	<input checked="" type="checkbox"/> NO	X
AP	2001-156738	06/08/2001	JAPAN	<input type="checkbox"/> YES	<input checked="" type="checkbox"/> NO	X
AQ				<input type="checkbox"/> YES	<input type="checkbox"/> NO	
AR				<input type="checkbox"/> YES	<input type="checkbox"/> NO	
AS				<input type="checkbox"/> YES	<input type="checkbox"/> NO	
AT				<input type="checkbox"/> YES	<input type="checkbox"/> NO	
AU				<input type="checkbox"/> YES	<input type="checkbox"/> NO	
AV				<input type="checkbox"/> YES	<input type="checkbox"/> NO	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)						
AW						
AX						
AY						
AZ						
Examiner	<i>S. J. S.</i>			Date Considered <i>1/15/05</i>		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered—Include copy of this form with next communication to applicant.</small>						

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LIST OF REFERENCES CITED BY APPLICANT  FEB 13 2002 O I P E PATENT & TRADEMARK OFFICE		APPLICANT		Takashi SEKI, et al.			
		FILING DATE November 16, 2001		GROUP 2681			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
AA							
AB							
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO	
AO		2954570	09/27/99	JAPAN	<input checked="" type="checkbox"/>	X	
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AQ							
AR							
AS							
AT							
AU							
AV							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner 				Date Considered 			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							